# Product Preview

# **Power MOSFET**

# 60 V, 1.5 m $\Omega$ , 294 A, Single N–Channel, D<sup>2</sup>PAK7

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	Э	_	V <sub>GS</sub>	±20	V
Continuous Drain Current $R_{\theta JC}$ (Note 2)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	294	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	Oldic		P <sub>D</sub>	246	W
$\begin{array}{c} \text{Continuous Drain} \\ \text{Current R}_{\theta JA} \\ \text{(Notes 1, 2)} \end{array}$	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	36	Α
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)	State	, ,	P <sub>D</sub>	3.8	W
Pulsed Drain Current	$T_A = 25^\circ$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	TBD	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	ç
Source Current (Body Diode)			I <sub>S</sub>	TBD	Α
$ \begin{array}{c} \text{Single Pulse Drain-to-Source Avalanche} \\ \text{Energy (I}_{L} = \text{TBD A}_{pk}, \ L = \text{TBD mH}) \end{array} $			E <sub>AS</sub>	TBD	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

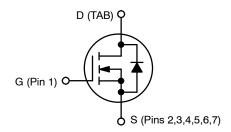
- 1. Surface-mounted on FR4 board using a 1 in2, 1 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



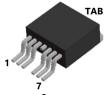
## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	1.5 mΩ @ 10 V	294 A
00 V	TBD mΩ @ 6 V	25474



**N-CHANNEL MOSFET** 



D<sup>2</sup>PAK7 CASE 418AY





XXXX = Specific Device Code
A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBGS1D5N06C	D <sup>2</sup> PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	0.61	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	40	

# ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	$I_D = 318 \mu A$ , ref to 25°C			TBD		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
	$V_{DS} = 60 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$		T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	: 318 μA	2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 318 μA, ref	to 25°C		TBD		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, $I_D$	= 64 A		TBD	1.5	0
		$V_{GS} = 6 \text{ V}, I_D$	= 32 A		TBD		mΩ
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D}$	= 64 A		TBD		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25°C			1.0		Ω
CHARGES, CAPACITANCES & GATE RESIS	TANCE					•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V, f = 1 MHz			7181		
Output Capacitance	C <sub>OSS</sub>				4265		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				39		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V; I <sub>D</sub> = 64 A			88		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				TBD		
Gate-to-Source Charge	Q <sub>GS</sub>				31		
Gate-to-Drain Charge	$Q_{GD}$				13		
Total Gate Charge	Q <sub>G(TOT)</sub>				TBD		
SWITCHING CHARACTERISTICS (Note 4)					•		•
Turn-On Delay Time	t <sub>d(ON)</sub>				TBD		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 30 V, $I_{D}$ = 64 A, $R_{G}$ = 6 $\Omega$			TBD		- ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				TBD		
Fall Time	t <sub>f</sub>				TBD		
DRAIN-SOURCE DIODE CHARACTERISTIC					•		
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 64 A	T <sub>J</sub> = 25°C		TBD	1.2	
			T <sub>J</sub> = 125°C		TBD		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 32 \text{ A}$			TBD		
Charge Time	t <sub>a</sub>				TBD		ns
Discharge Time	t <sub>b</sub>				TBD		1
Reverse Recovery Charge	Q <sub>RR</sub>				TBD		nC

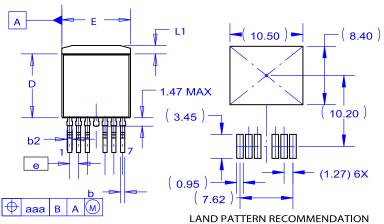
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

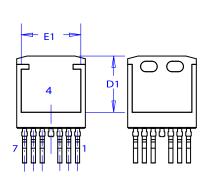
3. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

4. Switching characteristics are independent of operating junction temperatures.

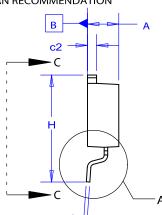
### **PACKAGE DIMENSIONS**

## D<sup>2</sup>PAK7 (TO-263 7 LD) CASE 418AY ISSUE B





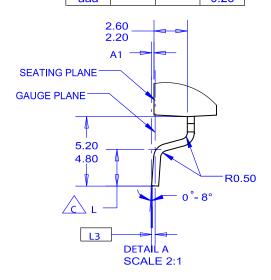
OPTIONAL CONSTRUCTIONS
VIEW C-C
SCALE 2: 1



#### NOTES:

- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
- Y14,5-1994.
  E. DIMENSIONS ARE EXCLUSIVE OF BURRS,
  MOLD FLASH AND TIE BAR PROTRUSIONS.
  F. LAND PATTERN RECOMMENDATION PER IPC.
  TO127P1524X465-8N.

DIM	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	4.30	4.50	4.70			
A1	0.00	0.10	0.20			
b2	0.70	0.80	0.90			
b	0.51	0.60	0.70			
С	0.40	0.50	0.60			
c2	1.20	1.30	1.40			
D	9.00	9.20	9.40			
D1	6.70	6.80	6.95			
Е	9.70	9.90	10.20			
E1	7.80	7.90	8.00			
e	~	1.27	~			
Ι	15.10	15.40	15.70			
L	2.44	2.64	2.84			
L1	1.00	1.20	1.40			
L3	~	0.25	~			
aaa	~	~	0.25			



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